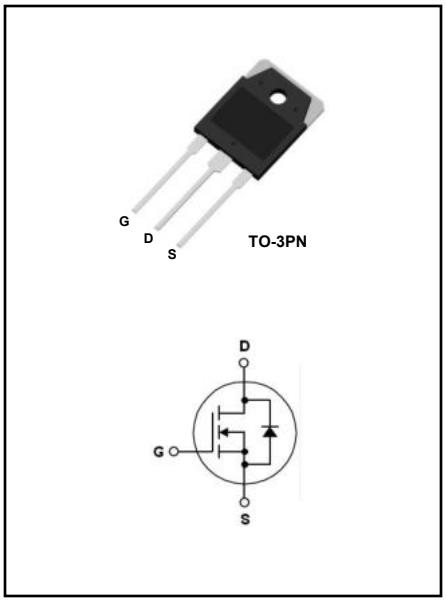
500V 18A N-Channel Enhancement Mode Power MOSFET

Description

The AKT18N50NE is an N-Channel enhancement mode power MOSFET, it has low static on-resistance and high avalanche energy strength. This device provide excellent switching performance for UPS,DC-DC converters and AC-DC power supply.



Features

- Low on-Resistance: $R_{DS\ (on)}$=0.24Ω(typ.)
- Special Process Technology for high ESD Capability
- 100% Avalanche Test
- Good Stability and Uniformity with High E_{AS}

Applications

- UPS Applications
- DC-DC Converters and AC-DC Power Supply

Absolute Maximum Ratings @T_C=25 ℃ unless otherwise noted

Symbol	Parameter		Ratings	Unit
V_{DSS}	Drain to Source Voltage		500	V
V_{GSS}	Gate to Source Voltage		±30	V
I_D	Drain Current	T_C=25℃	18	A
		T_C=100℃	10.8	A
I_{DM}	Pulsed Drain Current (Note1)		72	A
P_D	Maximum Power Dissipation	T_C=25℃	230	W
	Derate above 25℃		1.78	W/℃
E_{AS}	Single Pulsed Avalanche Energy (Note 2)		1298	mJ
T_J	Operating Junction Temperature Range		-55~+150	℃
T_{STG}	Storage Temperature Range		-55~+150	℃

Thermal Characteristics

Symbol	Parameter	Ratings	Unit
$R_{th\ (J-C)}$	Thermal Resistance, Junction to case	0.55	℃/W
$R_{th\ (J-A)}$	Thermal Resistance, Junction to Ambient	60	℃/W

Electrical Characteristics @T_C=25 ℃ unless otherwise noted

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain to Source Breakdown Voltage	V_{GS}=0V, I_D=250uA	500	-	-	V
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_D=250uA	3.0	3.8	4.8	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS}=10V, I_D=9A	-	0.24	0.26	Ω
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=V_{DSS}, V_{GS}=0V	-	-	1	uA
I_{GSS}	Gate to Source Leakage Current	V_{GS}=V_{GSS}, V_{DS}=0V	-	-	±100	nA

D-S Diode Characteristics and Maximum Rating @T_C=25 ℃ unless otherwise noted

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_S	Maximum Drain to Source Diode Forward Current		-	-	18	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS}=0V, I_S=18A	-	0.90	1.25	V
T_{rr}	Reverse Recovery Time	V_{GS}=0V, I_S=18A, di/dt=-100A/us	-	0.55	-	us
Q_{rr}	Reverse Recovery Charge		-	5.5	-	uC

Switching Characteristics @T_C=25 ℃ unless otherwise noted

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on Delay Time	I_D=18A, V_{DD}=250V, R_G=25Ω (Note 3)	-	70	-	ns
t_r	Turn-on Rise Time		-	50	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	100	-	ns
t_f	Turn-off Fall Time		-	30	-	ns
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=25V, f=1.0MHz	-	2500	-	pF
C_{oss}	Output Capacitance		-	400	-	pF
C_{rss}	Reverse Transfer Capacitance		-	40	-	pF
Q_g	Total Gate Charge	I_D=18A, V_{DS}=400V V_{GS}=10V (Note 3)	-	77	-	nC
Q_{gs}	Gate to Emitter Charge		-	33	-	nC
Q_{gd}	Gate to Collector Charge		-	12	-	nC

Note:

1. Repetitive rating: pulse-width limited by maximum junction temperature
2. L=8.0mH, I_{AS}=18A, V_{DD}=50V, V_G=10V, @T_C=25℃
3. Essentially independent of operating temperature typical characteristics

Typical Performance Characteristics

Fig. 1. Typical on-Resistance Characteristics

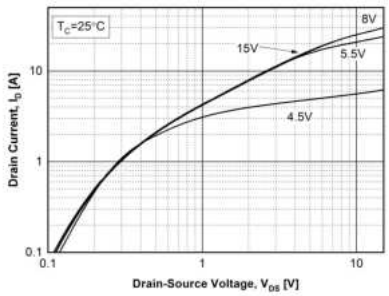


Fig. 2. Typical Transfer Characteristics

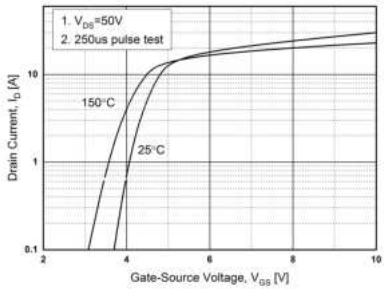


Fig. 3. Static on-Resistance vs. I_D

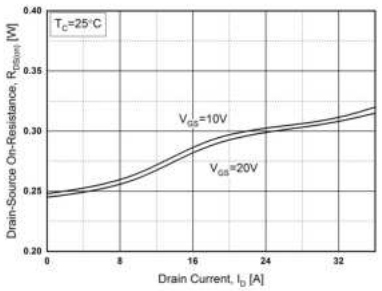


Fig. 4. Body Diode Forward Voltage vs. I_{DR}

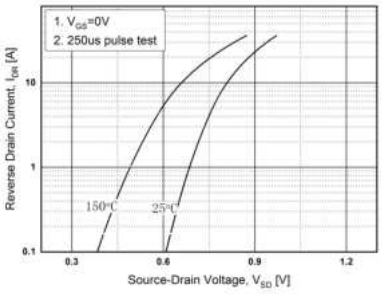


Fig. 5. Capacitance Characteristics

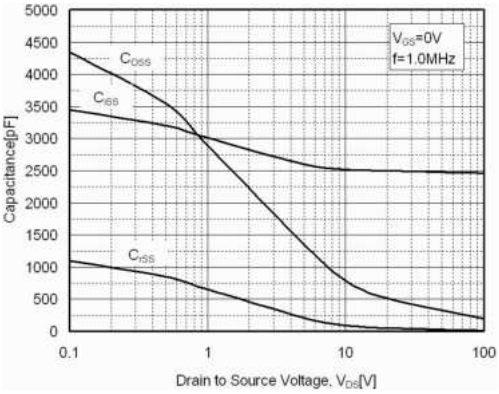
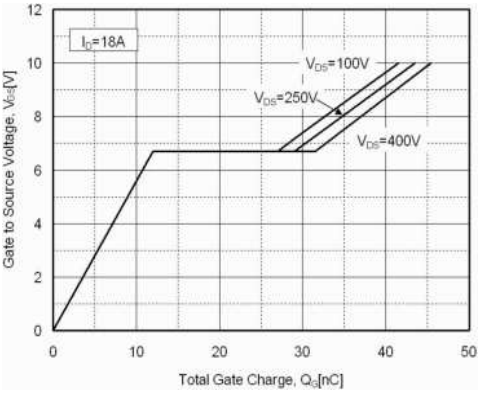


Fig. 6. Gate Charge Characteristics



Typical Performance Characteristics

Fig. 7. Breakdown Voltage vs. Temperature

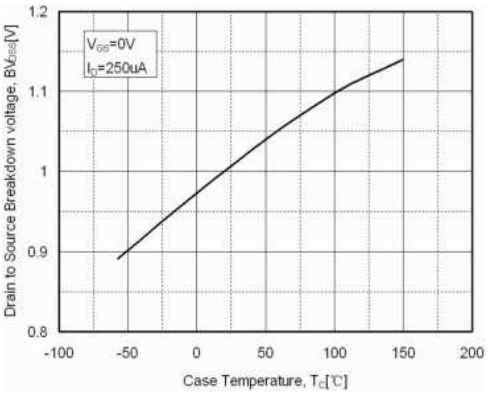


Fig. 8. Static on-Resistance vs. Temperature

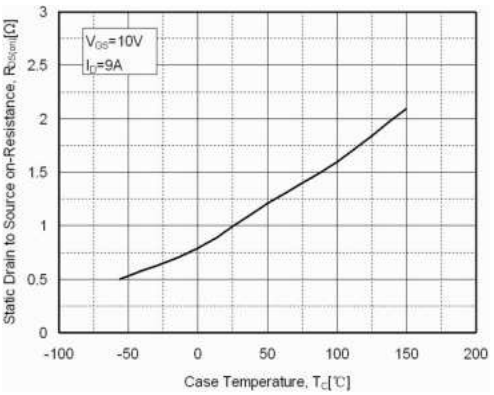


Fig. 9. Maximum Safe Operating Area

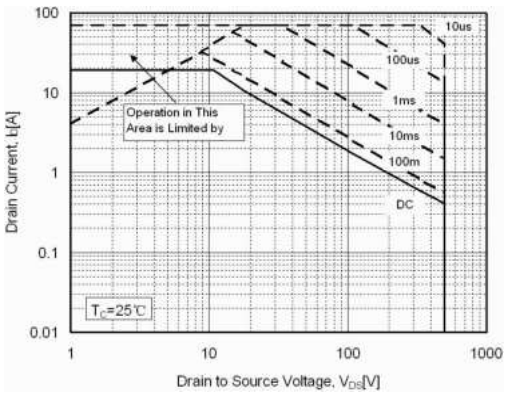


Fig. 10. Maximum Drain Current vs. Temperature

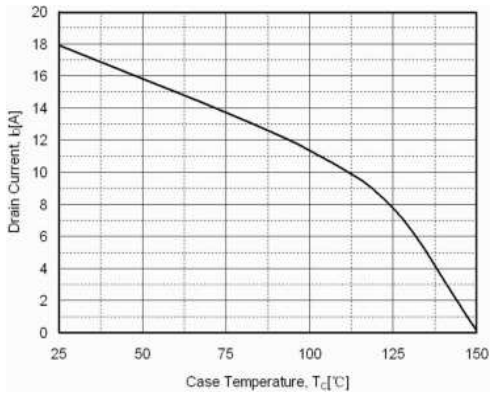
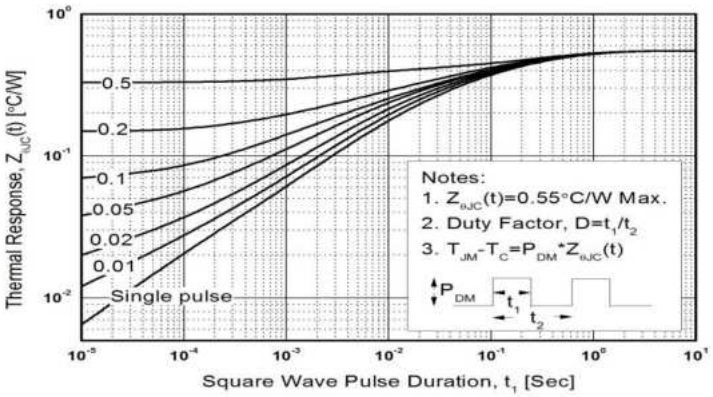


Fig. 11. Transient Thermal Response Curve



Package Dimensions

TO-3PN

(Dimensions in Millimeters)